Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,190	GROEN, ERIC D.	
Examiner	Art Unit	
Erin M. File	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	219	10/23/2006	EMF		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	11/1/2006	EMF
PALM INVENTORSHIP	10/23/2006	EMF
PLUS Search	10/23/2006	EMF
IEEE Keyword SearchSee Search Printout History	11/1/2006	EMF
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